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(Modified)U.S. DEPARTMENT OF COMMERCE  
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249612US2S DIVSERIAL NO.  
New DIV Application

## LIST OF REFERENCES CITED BY APPLICANT

APPLICANT  
Hideo ANDO, et al.FILING DATE  
Herewith

GROUP

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
RL	AA	5,440,631	08/1995	Akiyama, et al.			
RL	AB	5,771,334	06/1998	Yamauchi, et al.			
RL	AC	5,857,021	01/1999	Kataoka, et al.			
RL	AD	6,047,103	04/2000	Yamauchi, et al.			
RL	AE	6,088,312	07/2000	Utsumi, et al.			
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
RL	AO	6-103317	04/15/94	Japan	x	
RL	AP	8-221948	08/30/1996	Japan (w/English Translation)	x	
RL	AQ	6-349248	12/1994	Japan		
	AR					
	AS					
	AT					
	AU					
	AV					

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

RL	AW	Explanation of Circumstances Concerning Accelerated Examination for Japanese Patent Application No. AD09805001				
RL	AX	Explanation of Circumstances Concerning Accelerated Examination for Japanese Patent Application No. AD00103788				
RL	AY	Explanation of Circumstances Concerning Accelerated Examination for Japanese Patent Application No. AD00103787				
	AZ					

☐ Additional References sheet(s) attached

Examiner

*Robert Chualar*

Date Considered

*10/18/05*

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.